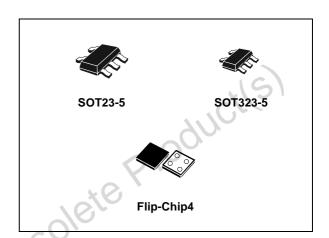




# LOW VOLTAGE CMOS SINGLE INVERTER WITH 5V TOLERANT INPUT

- **■** 5V TOLERANT INPUTS
- HIGH SPEED: t<sub>PD</sub> = 4.2ns (MAX.) at V<sub>CC</sub> = 3V
- LOW POWER DISSIPATION:  $I_{CC} = 1\mu A \text{ (MAX.)}$  at  $T_A = 25^{\circ}\text{C}$
- POWER DOWN PROTECTION ON INPUTS AND OUTPUTS
- SYMMETRICAL OUTPUT IMPEDANCE: |I<sub>OH</sub>| = I<sub>OL</sub> = 24mA (MIN) at V<sub>CC</sub> = 3V
- BALANCED PROPAGATION DELAYS: t<sub>PLH</sub> ≅ t<sub>PHL</sub>
- OPERATING VOLTAGE RANGE:
   V<sub>CC</sub>(OPR) = 1.65V to 5.5V
   (1.2V Data Retention)
- IMPROVED LATCH-UP IMMUNITY



#### **DESCRIPTION**

The 74LX1G04 is a low voltage CMOS SINGLE INVERTER fabricated with sub-micron silicon gate and double-layer metal wiring C<sup>2</sup>MOS technology.

It is ideal for 1.65 to 5.5  $V_{CC}$  operations and low power and low noise applications. The internal circuit is composed of 3 stages including buffer output, which provide high noise immunity and stable output.

Power down protection is provided on input and output and 0 to 7V can be accepted on inputs with

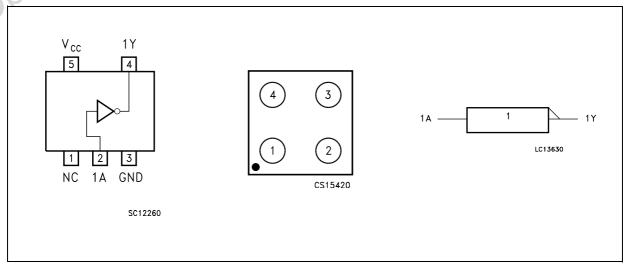
#### **ORDER CODES**

PACKAGE	T & R
SOT23-5L	74LX1G04STR
SOT323-5L	74LX1G04CTR
Flip-Chip	74LX1G04BJR

no regard to the supply voltage. It can be interfaced to 5V signal environment for inputs in mixed 3.3/5V system.

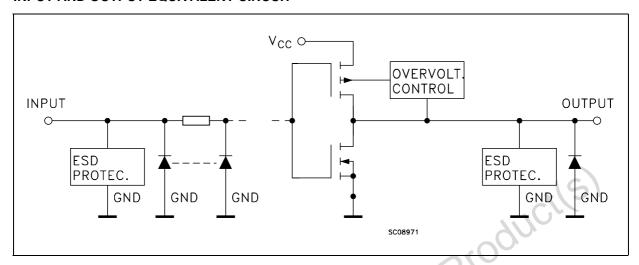
All inputs and outputs are equipped with protection circuits against static discharge.

#### PIN CONNECTION AND IEC LOGIC SYMBOLS (top view for SOT, top through view for Flip-Chip)



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#### INPUT AND OUTPUT EQUIVALENT CIRCUIT



#### **PIN DESCRIPTION**

PIN for SOT	PIN for Flip-Chip	SYMBOL	NAME AND FUNCTION
1		N.C.	Not connected
2	1	1A	Data Input
4	3	1Y	Data Output
3	2	GND	Ground (0V)
5	4	$V_{CC}$	Positive Supply Voltage

#### **TRUTH TABLE**

A	Y
	Н
H	L

### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply Voltage	-0.5 to +7.0	V
V <sub>I</sub>	DC Input Voltage	-0.5 to +7.0	V
Vo	DC Output Voltage (V <sub>CC</sub> = 0V)	-0.5 to +7.0	V
Vo	DC Output Voltage (High or Low State) (note 1)	-0.5 to V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	DC Input Diode Current	- 50	mA
I <sub>OK</sub>	DC Output Diode Current (note 2)	- 50	mA
Io	DC Output Current	± 50	mA
I <sub>CC</sub> or I <sub>GND</sub>	DC V <sub>CC</sub> or Ground Current per Supply Pin	± 50	mA
T <sub>stg</sub>	Storage Temperature	-65 to +150	°C
TL	Lead Temperature (10 sec)	260	°C

Absolute Maximum Rating are those value beyond which damage to the device may occur. Functional operation under these condition is not implied
1) I<sub>O</sub> absolute maximum rating must be observed
2) V<sub>O</sub> < GND

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol		Parameter		Value	Unit
V <sub>CC</sub>	Supply Voltage (no	te 1)	1.65 to 5.5	V	
VI	Input Voltage			0 to 5.5	V
Vo	Output Voltage (V <sub>C</sub>	C = 0V)		0 to 5.5	V
Vo	Output Voltage (Hig	gh or Low State)		0 to V <sub>CC</sub>	V
I <sub>OH</sub> , I <sub>OL</sub>	High or Low Level	Output Current (V <sub>CC</sub> = 4.5 to 5.5)	/)	± 32	mA
I <sub>OH</sub> , I <sub>OL</sub>	High or Low Level	Output Current ( $V_{CC} = 3.0 \text{ to } 3.6$ )	± 24	mA	
I <sub>OH</sub> , I <sub>OL</sub>	High or Low Level	Output Current (V <sub>CC</sub> = 2.7 to 3.0)	± 16	mA	
I <sub>OH</sub> , I <sub>OL</sub>	High or Low Level	Output Current (V <sub>CC</sub> = 2.3 to 2.7)	±8 (C	mA	
I <sub>OH</sub> , I <sub>OL</sub>	High or Low Level	Output Current ( $V_{CC} = 1.65$ to 2.3	BV)	± 4	mA
T <sub>op</sub>	Operating Tempera	ture		-55 to 125	°C
dt/dv	Input Rise and Fall	Time (note 2)		0 to 10	ns/V
•	guaranteed: 1.2V to 3.6 8V to 2V at $V_{CC} = 3.0V$	SV		Pro	
DC SPECI	IFICATION		16		
		Test Condition	20/	Value	

<sup>1)</sup> Truth Table guaranteed: 1.2V to 3.6V

#### DC SPECIFICATION

		Tes	st Condition	Value				
Symbol	Symbol Parameter		002	-40 to	85 °C	-55 to	125 °C	Unit
	(V)	V <sub>CC</sub>		Min.	Max.	Min.	Max.	
V <sub>IH</sub>	High Level Input	1.65 to 1.95	-	0.75V <sub>CC</sub>		0.75V <sub>CC</sub>		
	Voltage	2.3 to 2.7	01	0.7V <sub>CC</sub>		0.7V <sub>CC</sub>		V
		3.0 to 5.5		0.7V <sub>CC</sub>		$0.7V_{CC}$		
$V_{IL}$	Low Level Input	1.65 to 1.95			0.25V <sub>CC</sub>		0.25V <sub>CC</sub>	
	Voltage	2.3 to 2.7			0.3V <sub>CC</sub>		0.3V <sub>CC</sub>	V
		3.0 to 5.5			0.3V <sub>CC</sub>		0.3V <sub>CC</sub>	
V <sub>OH</sub>	High Level Output	1.65 to 4.5	I <sub>O</sub> =-100 μA	V <sub>CC</sub> -0.1		V <sub>CC</sub> -0.1		
	Voltage	1.65	I <sub>O</sub> =-4 mA	1.2		1.2		
-01		2.3	I <sub>O</sub> =-8 mA	1.9		1.9		V
2		3.0	I <sub>O</sub> =-16 mA	2.4		2.4		V
P		5.0	I <sub>O</sub> =-24 mA	2.2		2.2		
		4.5	I <sub>O</sub> =-32 mA	3.8		3.8		
V <sub>OL</sub>	Low Level Output	1.65 to 4.5	I <sub>O</sub> =100 μA		0.1		0.1	
	Voltage	1.65	I <sub>O</sub> =4 mA		0.45		0.45	
		2.3	I <sub>O</sub> =8 mA		0.3		0.3	V
		3.0	I <sub>O</sub> =16 mA		0.4		0.4	V
		3.0	I <sub>O</sub> =24 mA		0.55		0.55	
		4.5	I <sub>O</sub> =32 mA		0.55		0.55	
I <sub>I</sub>	Input Leakage Current	1.65 to 5.5	$V_{I} = 0 \text{ to } 5.5V$		± 10		± 10	μΑ
l <sub>off</sub>	Power Off Leakage Current	0	$V_{I}$ or $V_{O} = 5.5V$		10		10	μΑ
I <sub>CC</sub>	Quiescent Supply Current	1.65 to 5.5	$V_I = V_{CC}$ or GND		10		10	μΑ



<sup>2)</sup>  $V_{IN}$  from 0.8V to 2V at  $V_{CC}$  = 3.0V

#### **AC ELECTRICAL CHARACTERISTICS**

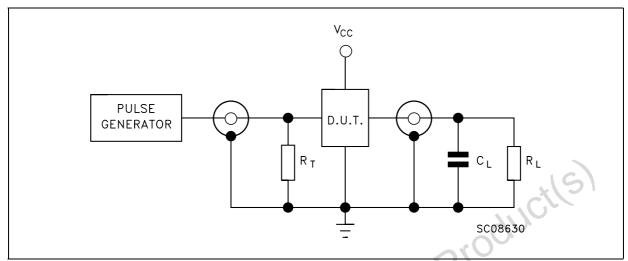
		Test Condition				Value											
Symbol	Parameter	V <sub>CC</sub> C <sub>L</sub>		R <sub>L</sub>	$R_L$ $t_s = t_r$ $(\Omega)$ $(ns)$	-40 to 85 °C		-55 to 125 °C		Unit							
		(V)		Min.		Max.	Min.	Max.									
t <sub>PLH</sub> t <sub>PHL</sub>	t <sub>PHL</sub> Propagation Delay Time	1.65 to 1.95				2	9.5	2	10.5								
		2.3 to 2.7	15	15 1MΩ	15 1MΩ	15 1MΩ	15 1ΜΩ	15 1MΩ	15 1ΜΩ	15	4.F. 4.M.O.	2.0	2	6.5	2	7.6	
		3.0 to 3.6									13	13	13	13	13   110152		13   110122
		4.5 to 5.5				1	4.1	1	5.5								
		1.65 to 1.95	30	1000	2.0	2	10.5	2	11.5	ns							
		2.3 to 2.7	30	500	2.0	2	7.5	2	8.5								
		2.7	50	500	2.5	1	6.1	1	7.1	) I							
		3.0 to 3.6	50	500	2.5	1	5.5	1	6.5								
		4.5 to 5.5	50	500	2.5	1	4.2	1	5.2								

#### **CAPACITANCE CHARACTERISTICS**

		Tes	Value				
Symbol	Parameter	V <sub>CC</sub>	16/10	•	T <sub>A</sub> = 25 °C		Unit
		(V)	cOlo	Min.	Тур.	Max.	
C <sub>IN</sub>	Input Capacitance	0	103		4		pF
C <sub>PD</sub>	Power Dissipation Capacitance	1.8	f <sub>IN</sub> = 10MHz		36.8		
	(note 1)	2.5			37		pF
	1.4	3.3			38		

<sup>1)</sup> C<sub>PD</sub> is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average current can be obtained by the following equation. I<sub>CC(opr)</sub> = C<sub>PD</sub> x V<sub>CC</sub> x f<sub>IN</sub> + I<sub>CC</sub>

#### **TEST CIRCUIT**

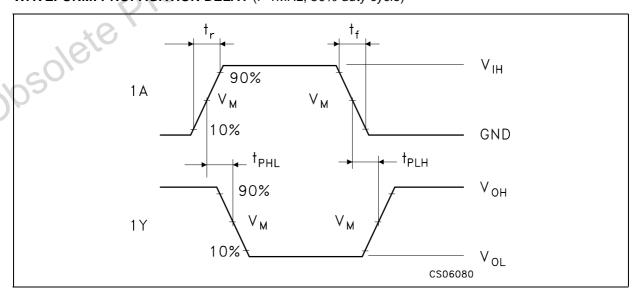


 $R_T = Z_{OUT}$  of pulse generator (typically  $50\Omega$ )

## TEST CIRCUIT AND WAVEFORM SYMBOL VALUE

Symbol		Vcc					
Symbol	1.65 to 1.95V	2.3 to 2.7V	2.7 to 5.5V				
$C_L$	15pF/30pF	15pF/30pF	15pF/50pF				
$R_{L}$	1ΜΩ/1000Ω	500Ω	500Ω				
V <sub>IH</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>				
V <sub>M</sub>	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2				
$t_r = t_r$	<2.0ns	<2.0ns	<2.5ns				

# WAVEFORM: PROPAGATION DELAY (f=1MHz; 50% duty cycle)



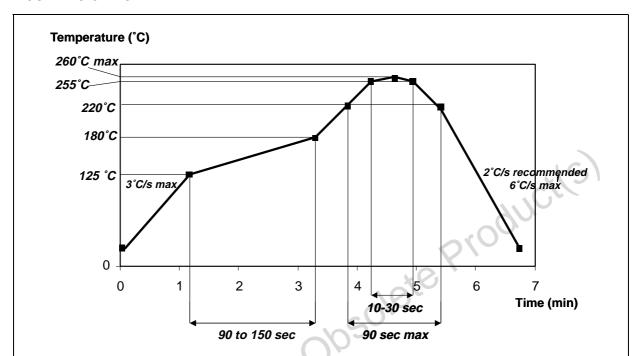


Figure 1 : RECOMMENDED SOLDERING REFLOW PROFILE FOR LEADFREE FLIP-CHIP MOUNTING ON PCB

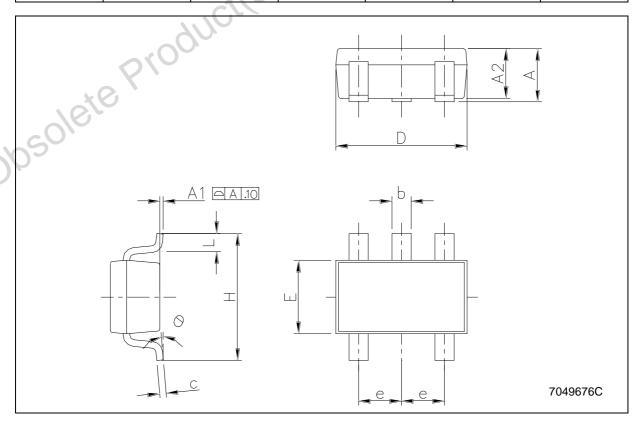
For Flip-Chip mounting on the PCB, STMicroelectronics recommends the use of a solder stencil aperture of 330 x 330  $\mu$ m<sup>2</sup> maximum and a typical stencil thickness of 125 $\mu$ m. Flip-Chips are fully compatible with the use of near eutectic 95.5Sn 4Ag 0.5Cu solder paste with no clean flux. ST's recommendations for Flip-Chip board mounting are illustrated on the soldering reflow profile shown in figure 1 below.

Dwell time in the soldering zone (with temperature higher than 220°C) has to be kept as short as possible to prevent component and substrate damages. Peak temperature must not exceed 260°C. Controlled atmosphere (N2 or N2H2) is recommended during the whole reflow, specially above 150°C.

Flip-Chips are able to withstand three times the previous recommended reflow profile in order to be compatible with a double reflow when SMDs are mounted on both sides of the PCB plus one additional repair. A maximum of three soldering reflows are allowed for these leadfree packages (with repair step included). The use of a no clean flux is highly recommended to avoid any cleaning operation. In order to prevent any bump cracks, ultrasonic cleaning methods are not recommended.

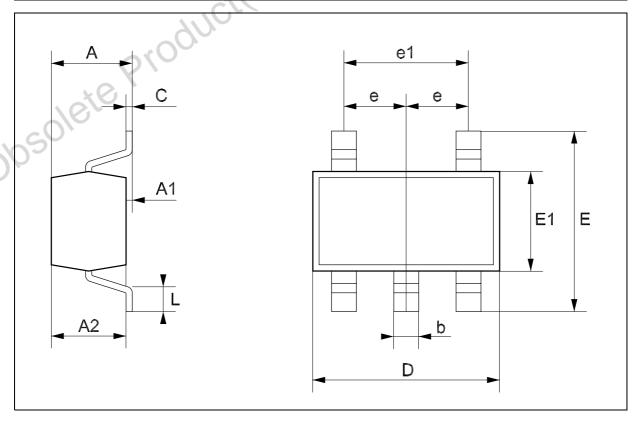
## **SOT23-5L MECHANICAL DATA**

DIM		mm.			mils	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	0.90		1.45	35.4		57.1
A1	0.00		0.10	0.0		3.9
A2	0.90		1.30	35.4		51.2
b	0.35		0.50	13.7	111	19.7
С	0.09		0.20	3.5	1000	7.8
D	2.80		3.00	110.2		118.1
Е	1.50		1.75	59.0		68.8
е		0.95	ans	0.	37.4	
Н	2.60		3.00	102.3		118.1
L	0.10	.15	0.60	3.9		23.6



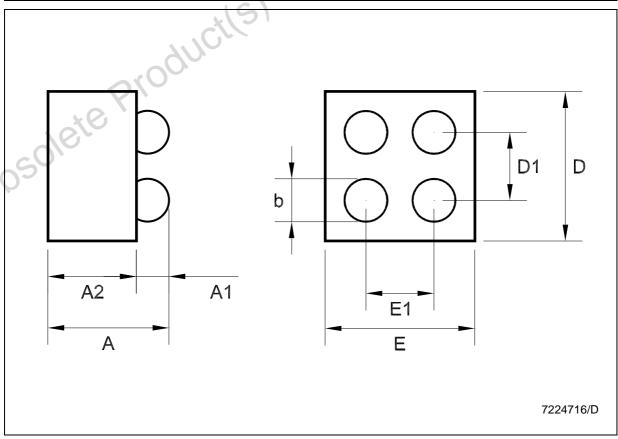
# **SOT323-5L MECHANICAL DATA**

DIM.		mm.				
DIIVI.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	0.80		1.10	31.5		43.3
A1	0.00		0.10	0.0		3.9
A2	0.80		1.00	31.5		39.4
b	0.15		0.30	5.9	.(	11.8
С	0.10		0.18	3.9	9/1/	7.1
D	1.80		2.20	70.9	260	86.6
E	1.80		2.40	70.9		94.5
E1	1.15		1.35	45.3		53.1
е		0.65	000		25.6	
e1		1.3	10.		51.2	
L	0.10	.15	0.30	3.9		11.8



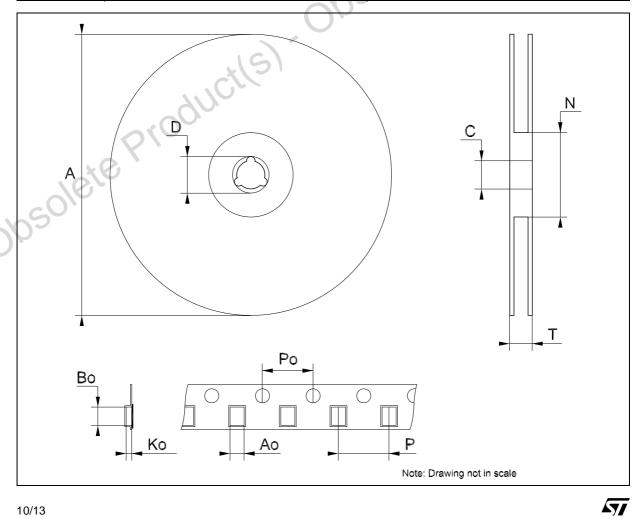
# Flip-Chip4 MECHANICAL DATA

DIM.		mm.			mils	
Dilvi.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	0.585	0.65	0.715	23.03	25.59	28.15
A1	0.21	0.25	0.29	8.27	9.84	11.42
A2		0.40			15.75	1(5)
b	0.265	0.315	0.365	10.43	12.40	14.37
D	1.02	1.07	1.12	40.15	42.13	44.09
D1		0.5		18,6	19.69	
E	1.02	1.07	1.12	40.15	42.13	44.09
E1		0.5	10,		19.69	

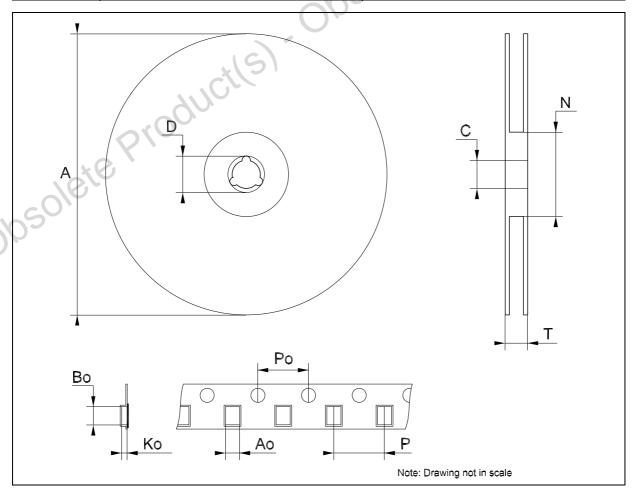


Tape & Reel SOT23-xL	<b>MECHANICAL</b>	<b>DATA</b>
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DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А			180			7.086
С	12.8	13.0	13.2	0.504	0.512	0.519
D	20.2			0.795		
N	60			2.362		.15
Т			14.4			0.567
Ao	3.13	3.23	3.33	0.123	0.127	0.131
Во	3.07	3.17	3.27	0.120	0.124	0.128
Ko	1.27	1.37	1.47	0.050	0.054	0.0.58
Po	3.9	4.0	4.1	0.153	0.157	0.161
Р	3.9	4.0	4.1	0.153	0.157	0.161

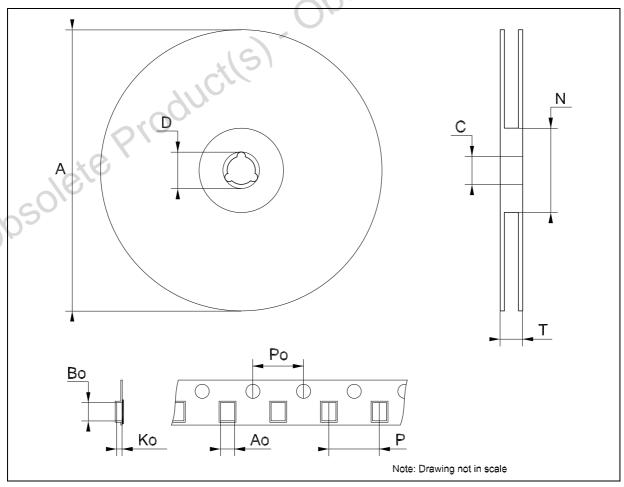


DIM	mm.			inch			
DIM.	MIN. TYP	MAX.	MIN.	TYP.	MAX.		
А	175	180	185	6.889	7.086	7.283	
С	12.8	13	13.2	0.504	0.512	0.519	
D	20.2			0.795			
N	59.5	60	60.5		2.362	115)	
Т			14.4			0.567	
Ao		2.25			0.088		
Во		2.7			0.106		
Ko		1.2		VO.	0.047		
Ро	3.9	4	4.1	0.153	0.157	0.161	
Р	3.8	4	4.2	0.149	0.157	0.165	



# Tape & Reel Flip-Chip 4 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α			178			6.926
С	12.8		13.2	0.504		0.519
D	20.2			0.795		
N	59	60	61	2.323	2.362	2.401
Т			8.4		(	0.331
Ao	1.12	1.17	1.22	0.044	0.046	0.048
Во	1.12	1.17	1.22	0.044	0.046	0.048
Ko	0.68	0.73	0.78	0.027	0.029	0.031
Po	3.9	4	4.1	0.153	0.157	0.161
Р	3.9	4	4.1	0.153	0.157	0.161





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